## PNJ4K01F

## Bipolar Integrated Circuit with Photodetection Function

#### For brightness control systems

#### ■ Features

- Peak sensitivity wavelength: 560 nm
- Output ratio of incandescent light and fluorescent light: 1.1 (typ.)
- Small, thin type package:  $1.55 \text{ mm} \times 1.5 \text{ mm} \times 0.53 \text{ mm}$
- Surface-mouting type for reflow soldering

#### ■ Absolute Maximum Ratings $T_a = 25$ °C

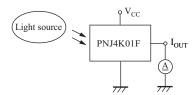
Parameter	Symbol	Rating	Unit	
Operating supply voltage	V <sub>CC</sub>	- 0.5 to +7.0	V	
Power dissipation	$P_{\mathrm{D}}$	35	mW	
Operating ambient temperature	T <sub>opr</sub>	-30 to +85	°C	
Storage temperature	T <sub>stg</sub>	-40 to +100	°C	

## ■ Electro-Optical Characteristics $T_a = 25$ °C±3°C, $V_{CC} = 3$ V

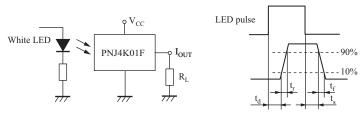
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Operating supply voltage	V <sub>CC</sub>		1.4	AL.	5.5	V
Saturation voltage *3	V <sub>O(sat)</sub>	$E_V = 100 \text{ lx}, R_L = 100 \text{ k}\Omega$	2.60	2.94	3.00	V
Supply current *1	$I_{CC}$	$E_V = 1000  lx,  R_L = 1  k\Omega$	Olym	480	920	μΑ
Output current 1 *1, *3	I <sub>O1</sub>	$E_V = 100 lx$	29.0	48.0	90.0	μΑ
Output current 2 *2, *3	$I_{O2}$	$E_V = 10 lx$	2.5	4.3	7.9	μΑ
Output current 3 *2, *3	$I_{O3}$	$E_V = 100 lx$	25.0	43.0	79.0	μΑ
Output current ratio	$I_{O1} / I_{O3}$	ingh inter		1.1	1.65	
Drain current	$I_{\mathrm{D}}$	$E_V = 0 lx$		10	100	nA
Peak sensitivity wavelength	$\lambda_{ ext{PD}}$	All Le Roll		560		nm
Rise time *4	t <sub>r</sub>	: SCOL VAILLE		100	1000	μs
Fall time *4	t <sub>f</sub>	$R_{\rm L} = 5.1 \text{ k}\Omega$		300	1000	μs
Delay time *4	t <sub>d</sub>	$K_{\rm L} = 3.1 \text{ K} \cdot 2$		50		μs
Storage time *4	t <sub>s</sub>	<u> </u>		5		μs

Note) \*1: Light source is CIE standard A light source. (Incandescent lamp)

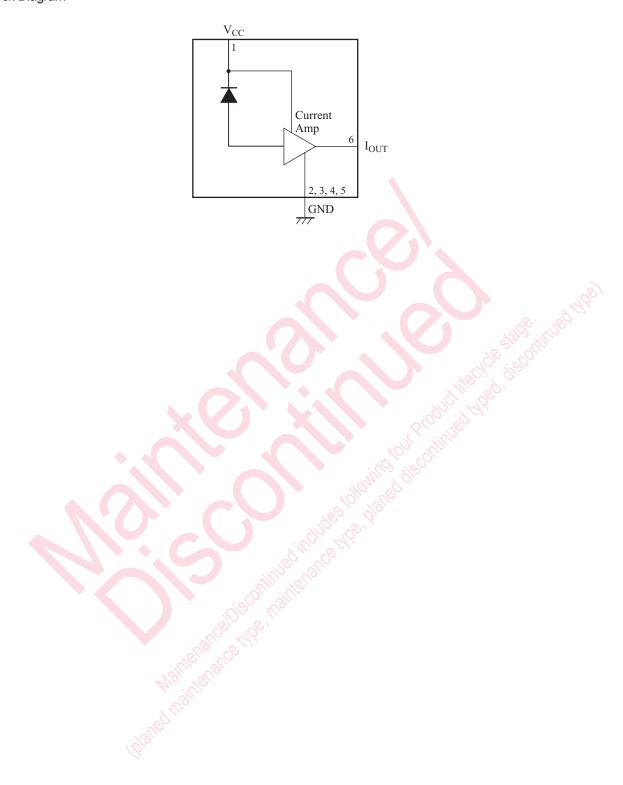
- \*2: Light source is fluorescence light.
- \*3: Output current measurement circuit



\*4: Switching time measurement method



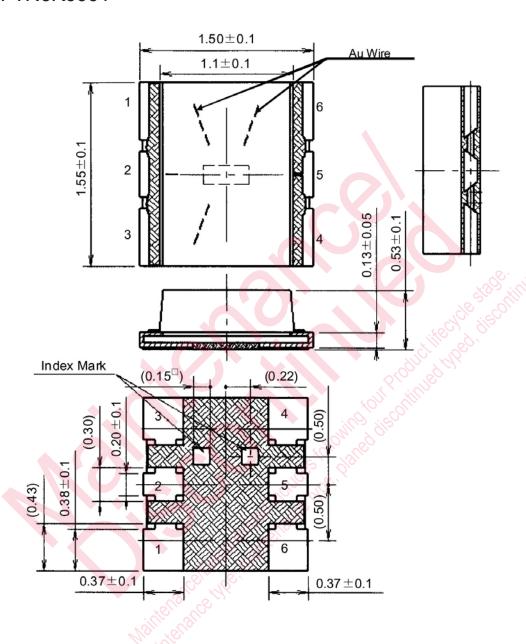
### ■ Block Diagram



2 Ver. AEK

#### ■ Package (Unit: mm)

## KPTFTN6K0001



- Pin name
  - 1: V<sub>CC</sub>
  - 2: GND
  - 3: GND
  - 4: GND
  - 5: GND
  - 6: I<sub>OUT</sub>

Ver. AEK 3

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